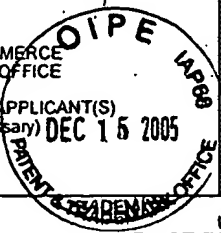


FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. <b>862.C2261</b>		APPLICATION NO. <b>09/877,092</b>	
<div style="border: 1px solid black; border-radius: 50%; padding: 10px; display: inline-block;">             DEC 15 2005              PATENT AND TRADEMARK OFFICE           </div>				APPLICANT <div style="text-align: center; font-weight: bold;">Takashi Arai</div>			
				FILING DATE <div style="text-align: center;">June 11, 2001</div>			GROUP <div style="text-align: center;">N.Y.A.</div>
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
[Signature]	3,268,639	08/23/66	Taft	264	78		
[Signature]	3,384,691	05/21/68	Weissman et al.	264	47		
[Signature]	3,796,779	03/12/74	Greenberg	264	50		
[Signature]	4,473,665	09/25/84	Martini-Vvedensky et al.	521	79		
[Signature]	5,158,986	10/27/92	Cha et al.	521	82		
[Signature]	5,160,674	11/03/92	Colton et al.	264	50		
[Signature]	5,334,356	08/02/94	Baldwin et al.	422	133		
[Signature]	5,571,848	11/05/96	Mortensen et al.	521	61		
[Signature]	5,866,053	02/02/99	Park et al.	264	50		
[Signature]	11/23/82	11/23/82	Rubens	264	28		
FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL	COUNTRY	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
[Signature]	JP	54-128728	10/05/79	Japan			Abstract
[Signature]	JP	49-111615	10/24/74	Japan			Abstract
[Signature]	JP	8-300392	11/19/96	Japan			Abstract
[Signature]	JP	10-24436	01/27/98	Japan			Abstract
[Signature]	JP	7-232358	09/05/95	Japan			Abstract
[Signature]	JP	9-48039	02/18/97	Japan			Abstract
[Signature]	JP	2000-25066	01/25/00	Japan			Abstract
[Signature]	EP	0662 383 A1	07/12/95	EPO			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER <div style="text-align: center;">[Signature]</div>				DATE CONSIDERED <div style="text-align: center;">1/4/06</div>			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

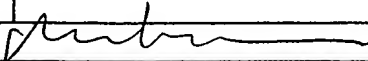
FORM PTO 1449, (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. <b>862.C2261</b>	APPLICATION NO. <b>09/877,092</b>
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)		APPLICANT <b>Takashi Arai</b>	
		FILING DATE <b>June 11, 2001</b>	GROUP <b>N.Y.A.</b>



U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
WJ	4,360,484	11/23/82	Rubens	264	28		

FOREIGN PATENT DOCUMENTS							
DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT		

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)	

EXAMINER 	DATE CONSIDERED <b>1/4/06</b>
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